## Measurement geometry

- Plane spacing $\mathrm{dz}=20 \mathrm{~mm}, \mathrm{dz}_{\text {SUT }}=15 \mathrm{~mm}$
- Total material budget telescope: $\varepsilon(\mathrm{M} 26+$ air $)=4.8 \mathrm{e}-3$



## Data analysis flow

Analysis done with EUTelescope *

- Conversion of Mimosa26 raw data to LCIO format
- Hot pixel search
- Cluster formation, remove clusters with hot pixels
- Construct triplets for up- and downstream plane
- Isolation cut on triplets

accepted
rejected
- Match up- and downstream triplets in the centre
$\rightarrow$ six-tuple from physical track

- Feed six-tuple to Millepede for alignment



## General Broken Lines

- GBL track model allows for kinks at scatterers
- Calculating corrections to an initial simple seed track
- Perform $\chi^{2}$ minimisation to find track parameters
- Simple track model:
 no bremsstrahlung, no non-Gaussian tails, no non-linear effects
- Inputs: Measurement + error, geometry, scattering estimate
- Outputs: residuals, residual width, kinks, track resolution
V. Blobel, C. Kleinwort, and F. Meier. Fast alignment of a complex tracking detector using advanced track models. Computer Physics Communications, 182(9):1760-1763, 2011.
C. Kleinwort. General broken lines as advanced track fitting method. Nucl. Instr. Meth. Phys. Res. A, 673:107-110, May 2012.


## Multiple scattering

- Variance predicted by Highland at a single scatterer:

$$
\Theta_{0}^{2}=\left(\frac{13.6 \mathrm{MeV}}{\beta c p} \cdot z\right)^{2} \cdot \varepsilon \cdot(1+0.038 \cdot \ln (\varepsilon))^{2}
$$



- For a composition of scatterers

$$
\varepsilon=\sum \varepsilon_{i}
$$



Highland predicts variance after last scatterer

- For individual scatterer within composition:


$$
\Theta_{0, i}^{2} \equiv \frac{\varepsilon_{i}}{\varepsilon} \cdot \Theta_{0}^{2}=\left(\frac{13.6 \mathrm{MeV}}{\beta c p} \cdot z\right)^{2} \cdot \varepsilon_{i} \cdot(1+0.038 \cdot \ln (\varepsilon))^{2}
$$

## Unbiased kinks

- Last slides: scatterers of known material budget $\rightarrow$ constrained kink angle in $\chi^{2}$ (biased)
- Goal: kink for unknown scatterer (unbiased)
$\rightarrow$ introduce free local parameters in track model
$\rightarrow$ dedicated track model for unbiased kinks



## A word on thick scatterers

- Assume a non-homogeneous scatterer along z

- Describe with three parameters: length s , mean $\overline{\mathrm{s}}$, variance $\Delta \mathrm{s} 2$

$$
\theta^{2}=\sum_{i} \theta_{i}^{2}, \quad \bar{s}=\frac{1}{\theta^{2}} \sum_{i} s_{i} \theta_{i}^{2}, \Delta s^{2}=\frac{1}{\theta^{2}} \sum_{i}\left(s_{i}-\bar{s}\right)^{2} \theta_{i}^{2}
$$

- Find a toy scatterer composed of two thin scatterers resembling the thick scatterer; $\mathrm{S}_{1}, \mathrm{~S}_{2}, \Theta_{1}, \Theta 2$.
- e.g. for homogeneous scatterer
$-\mathrm{s}_{1}=\bar{s}-\mathrm{d} / \mathrm{sqrt}(12)$
$-\mathrm{s}_{2}=\overline{\mathrm{s}}+\mathrm{d} / \mathrm{sqrt}(12)$
$-\Theta_{1}=\Theta_{2}=\Theta / 2$



## Inhomogeneous sample

- Can we resolve structured samples?
$\rightarrow$ electron-illuminated a coax connector



## Inhomogeneous sample

- Can we resolve structured samples?
$\rightarrow$ electron-illuminated a coax connector



## Inhomogeneous sample

- Can we resolve structured samples?
$\rightarrow$ electron-illuminated a coax connector



## Systematics

- Estimate systematic uncertainties of intrinsic resolution based on the input uncertainties

|  |  |  | $\sigma_{\sigma_{\text {int }}}$ in \% |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | per plane |  |  | all planes$\operatorname{rms}\left(p_{\mathrm{b}}\right)$ | $\sqrt{\sum\left(x_{i}\right)^{2}}$ |
|  |  |  | $\begin{gathered} E \\ \pm 5 \% \end{gathered}$ | $\begin{gathered} \Theta_{0} \\ \pm 3 \% \end{gathered}$ | fit range $\pm 1$ std. |  |  |
| 6 GeV | 20 mm | biased | -0.34 +0.21 | ${ }_{-0.28}^{+0.08}$ | ${ }^{+1.76}$ | 1.57 | 2.6 |
|  |  | unbiased | -0.43 +0.71 | ${ }_{-0.25}^{+0.44}$ | -0.93 -1.00 | 1.23 | 1.8 |
|  | 150 mm | biased | -3.5 | +1.95 | +6.4 | 1.51 | 7.9 |
|  |  |  | +2.9 -4.80 | -2.60 +2.97 | -5.4 |  |  |
|  |  | unbiased | -4.80 +5.43 | ${ }_{-4.13}^{+2.97}$ | -5.29 +3.11 | 0.75 | 8.7 |
| 2 GeV | 20 mm | biased | -1.56 +1.13 | ${ }_{-1.22}^{+0.65}$ | +0.23 +0.33 | 3.1 | 3.7 |
|  |  | unbiased | -1.67 | ${ }_{-110}^{+0.92}$ | -2.15 +1.35 | 1.94 | 3.1 |
|  | 150 mm | biased | -10.5 | +10.2 | +8.0 | 0.82 | 20.3 |
|  |  | biased | +15.7 | -6.59 | +0.82 | 0.82 | 20.3 |
|  |  | unbiased | -17.5 +24.9 | ${ }_{-15.2}^{+14.9}$ | -23.9 +25.1 | 1.03 | 38.5 |

## Track resolution predictions

- Using 6 planes, assuming DUT in the centre


$\rightarrow$ Thick DUT: use wide set-up Thin DUT: use narrow set-up


## Track resolution predictions

- Using 6 planes, assuming DUT in the centre
- Wide set-up offers superior track resolution with thicker DUTs and vice versa.
- Intersection is function of material budget
$\rightarrow$ Optimise resolution prior to your test beam



## Looking even closer ...

CS 1
Fold occurrence into one pixel for intra-pixel studies


GBL in-pixel occurrence of CS1


CS 3
GBL in-pixel occurrence of CS3
$\rightarrow$ Density of recon. track position is non-uniform, it depends on cluster size $\rightarrow$ Populated areas differ in size $\rightarrow$ Resolution is CS dependent
$\rightarrow$ Calculate differential intrinsic resolution


GBL in-pixel occurrence of CS4


